Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/824,430	MITSUZAWA, TOYOHIKO
Examiner	Art Unit
Julian D. Huffman	2853

Julian D. Huffman

	SEAR	CHED	
Class	Subclass	Date	Examiner
	<u>-</u>		

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		1	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
347/19, 40-42,13, text search É	7/28/2006	JH
	-	